

**SIPMOS® Small-Signal-Transistor**
**Feature**

- N-Channel
- Enhancement mode
- Logic level
- dv/dt rated
- Pb-free lead-plating; RoHS compliant
- Qualified according to AEC Q101
- Halogen-free according to IEC61249-2-21

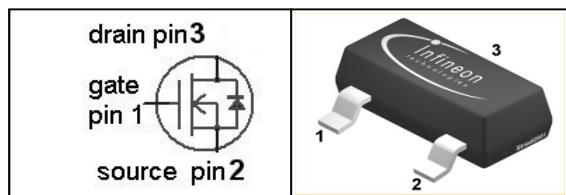


Halogen-Free

**Product Summary**

$V_{DS}$	240	V
$R_{DS(on),max}$	14	$\Omega$
$I_D$	0.1	A

PG-SOT-23



Type	Package	Pb-free	Tape and Reel Information	Marking
BSS131	PG-SOT23	Yes	H6327	SRs

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	$I_D$	$T_A=25\text{ }^\circ\text{C}$	0.11	A
		$T_A=70\text{ }^\circ\text{C}$	0.09	
Pulsed drain current	$I_{D,pulse}$	$T_A=25\text{ }^\circ\text{C}$	0.4	
Reverse diode dv/dt	dv/dt	$I_D=0.1\text{ A}$ , $V_{DS}=192\text{ V}$ , $di/dt=200\text{ A}/\mu\text{s}$ , $T_{j,max}=150\text{ }^\circ\text{C}$	6	kV/ $\mu\text{s}$
Gate source voltage	$V_{GS}$		$\pm 20$	V
ESD Class		JESD22-A114-HBM	Class 0	
Power dissipation	$P_{tot}$	$T_A=25\text{ }^\circ\text{C}$	0.36	W
Operating and storage temperature	$T_j$ , $T_{stg}$		-55 ... 150	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1			55/150/56	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Thermal characteristics**

Thermal resistance, junction - minimal footprint	$R_{\text{thJA}}$		-	-	350	K/W
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**Electrical characteristics**, at  $T_j=25$  °C, unless otherwise specified

**Static characteristics**

Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}}=0$ V, $I_D=250$ µA	240	-	-	V
Gate threshold voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=0$ V, $I_D=56$ µA	0.8	1.4	1.8	
Drain-source leakage current	$I_D$ (off)	$V_{\text{DS}}=240$ V, $V_{\text{GS}}=0$ V, $T_j=25$ °C	-	-	0.01	µA
		$V_{\text{DS}}=240$ V, $V_{\text{GS}}=0$ V, $T_j=150$ °C	-	-	5	
Gate-source leakage current	$I_{\text{GSS}}$	$V_{\text{GS}}=20$ V, $V_{\text{DS}}=0$ V	-	-	10	nA
Drain-source on-state resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}}=4.5$ V, $I_D=0.09$ A	-	9.07	20	Ω
		$V_{\text{GS}}=10$ V, $I_D=0.1$ A	-	7.7	14	
Transconductance	$g_{\text{fs}}$	$ V_{\text{DS}} >2 I_D R_{\text{DS}(\text{on})\text{max}},$ $I_D=0.08$ A	0.06	0.13	-	s

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Dynamic characteristics**

Input capacitance	$C_{iss}$	$V_{GS}=0 \text{ V}, V_{DS}=25 \text{ V}, f=1 \text{ MHz}$	-	58	77	pF
Output capacitance	$C_{oss}$		-	7.3	10	
Reverse transfer capacitance	$C_{rss}$		-	2.8	4.2	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=120 \text{ V}, V_{GS}=10 \text{ V}, I_D=0.1 \text{ A}, R_G=6 \Omega$	-	3.3	5.0	ns
Rise time	$t_r$		-	3.1	4.6	
Turn-off delay time	$t_{d(off)}$		-	13.7	20	
Fall time	$t_f$		-	64.5	97	

**Gate Charge Characteristics**

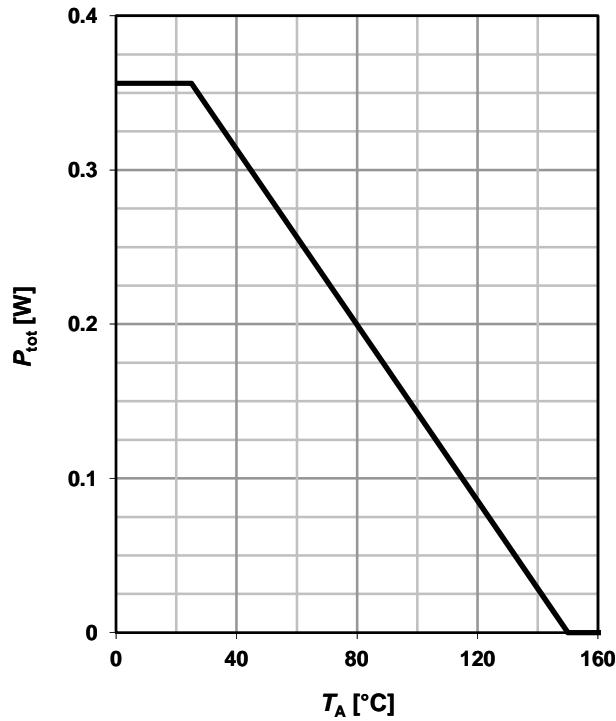
Gate to source charge	$Q_{gs}$	$V_{DD}=192 \text{ V}, I_D=0.1 \text{ A}, V_{GS}=0 \text{ to } 10 \text{ V}$	-	0.16	0.22	nC
Gate to drain charge	$Q_{gd}$		-	0.8	1.2	
Gate charge total	$Q_g$		-	2.1	3.1	
Gate plateau voltage	$V_{plateau}$		-	2.90	-	V

**Reverse Diode**

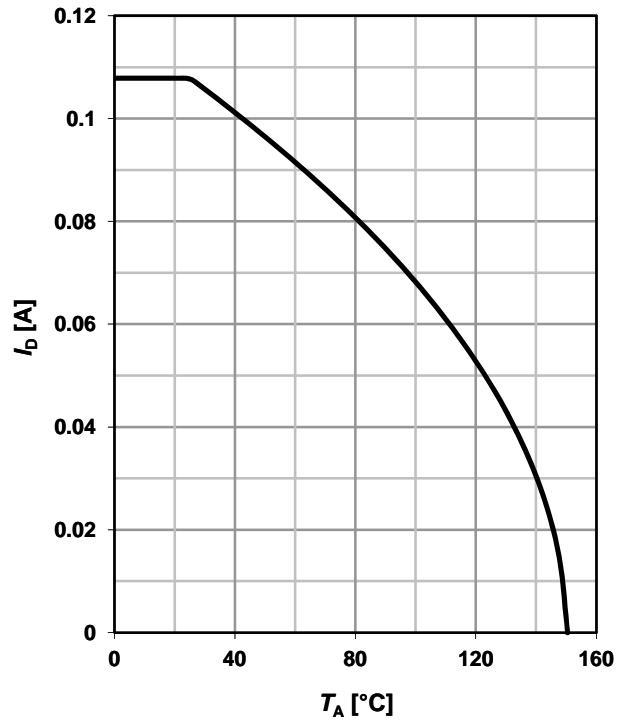
Diode continuous forward current	$I_s$	$T_A=25 \text{ }^\circ\text{C}$	-	-	0.11	A
Diode pulse current	$I_{s,pulse}$		-	-	0.43	
Diode forward voltage	$V_{SD}$	$V_{GS}=0 \text{ V}, I_F=0.1 \text{ A}, T_j=25 \text{ }^\circ\text{C}$	-	0.81	1.2	V
Reverse recovery time	$t_{rr}$	$V_R=120 \text{ V}, I_F=0.1 \text{ A}, di_F/dt=100 \text{ A}/\mu\text{s}$	-	42.9	64.3	ns
Reverse recovery charge	$Q_{rr}$		-	22.6	34	nC

**1 Power dissipation**

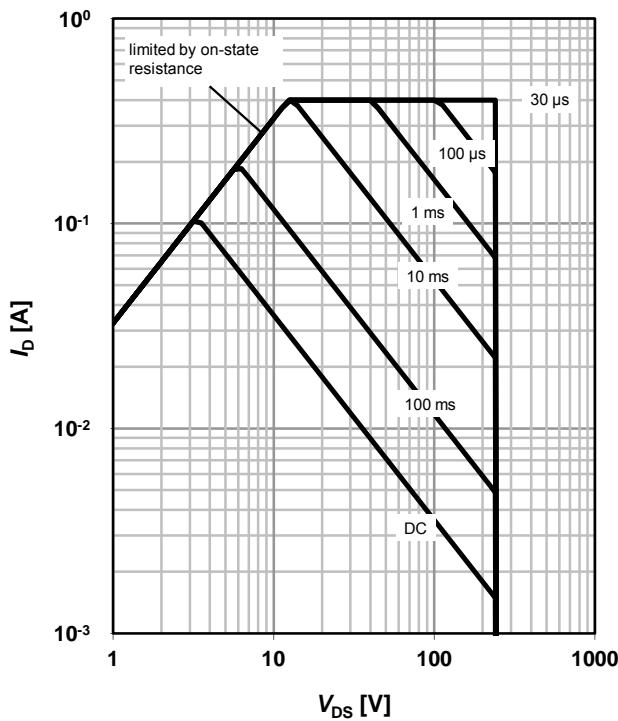
$$P_{\text{tot}} = f(T_A)$$


**2 Drain current**

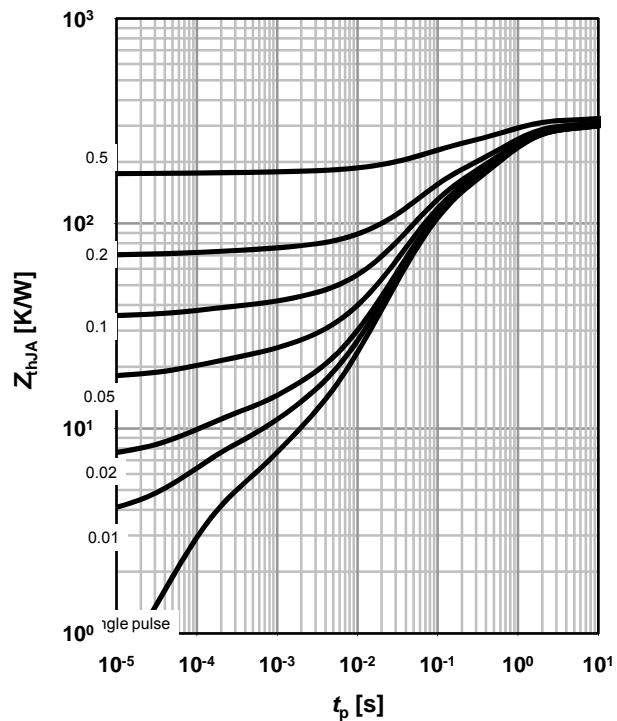
$$I_D = f(T_A); V_{GS} \geq 10 \text{ V}$$

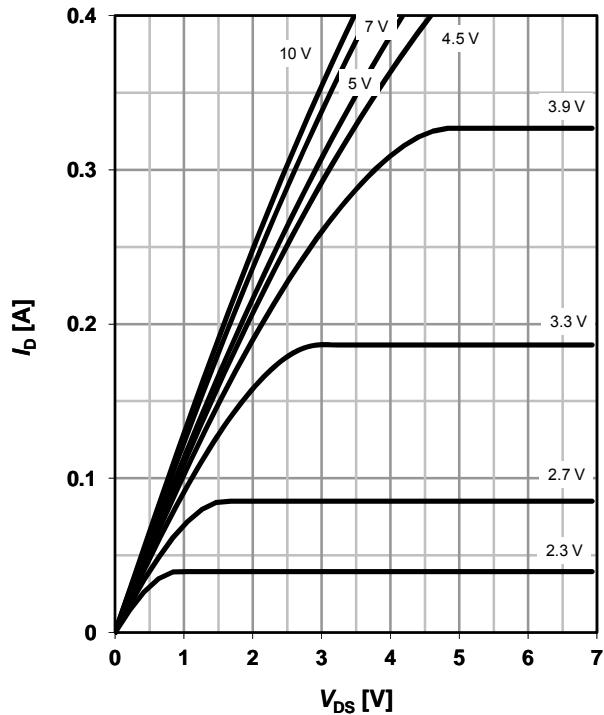
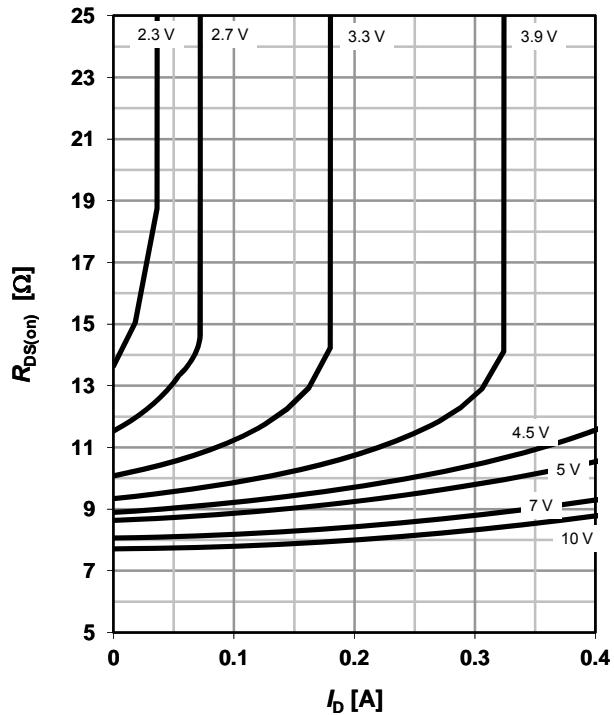
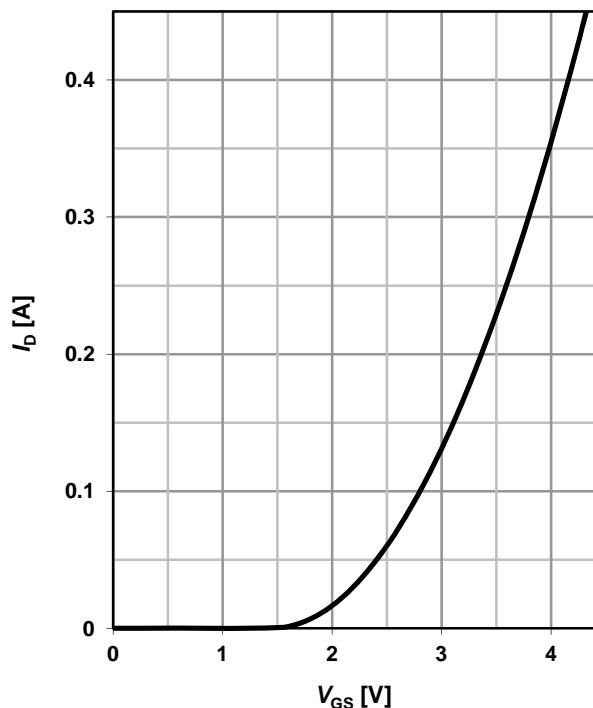
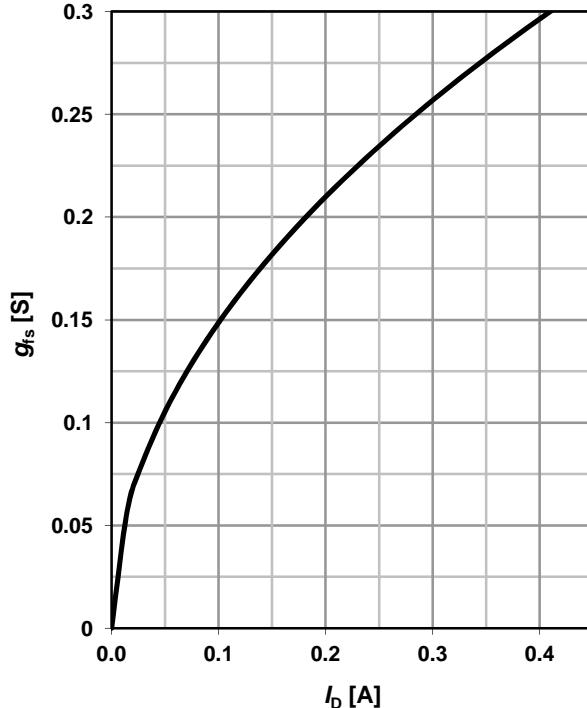

**3 Safe operating area**

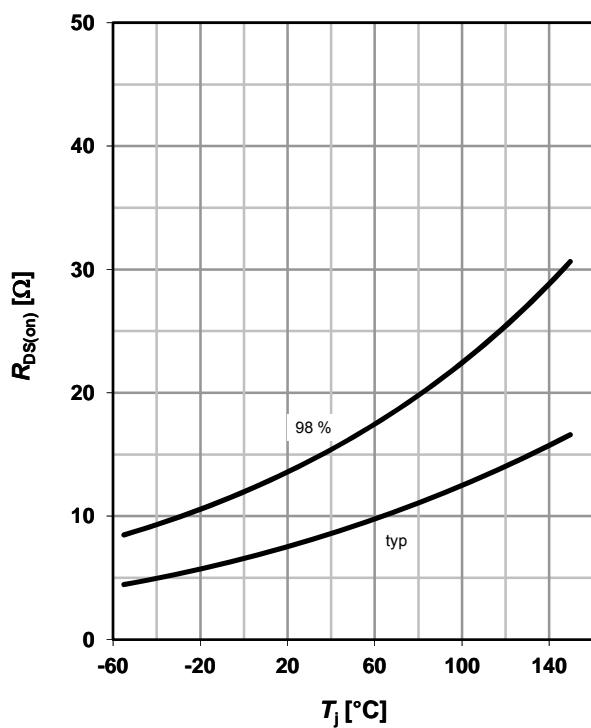
$$I_D = f(V_{DS}); T_A = 25 \text{ °C}; D = 0$$

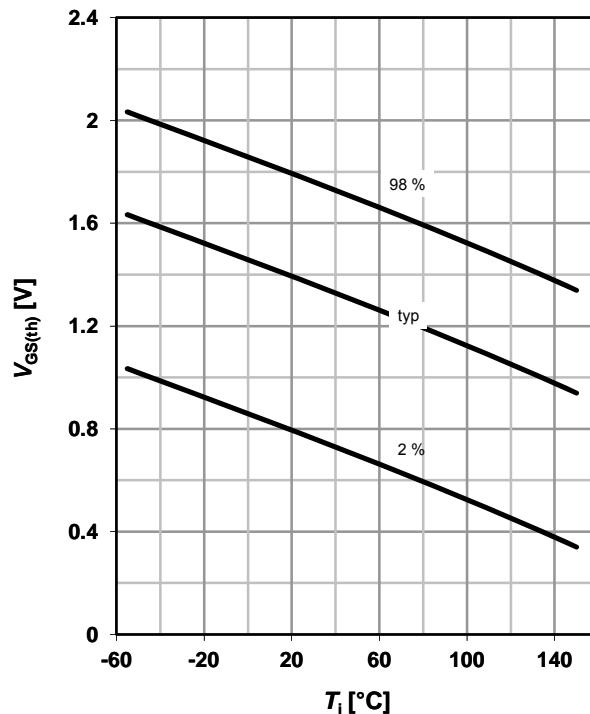
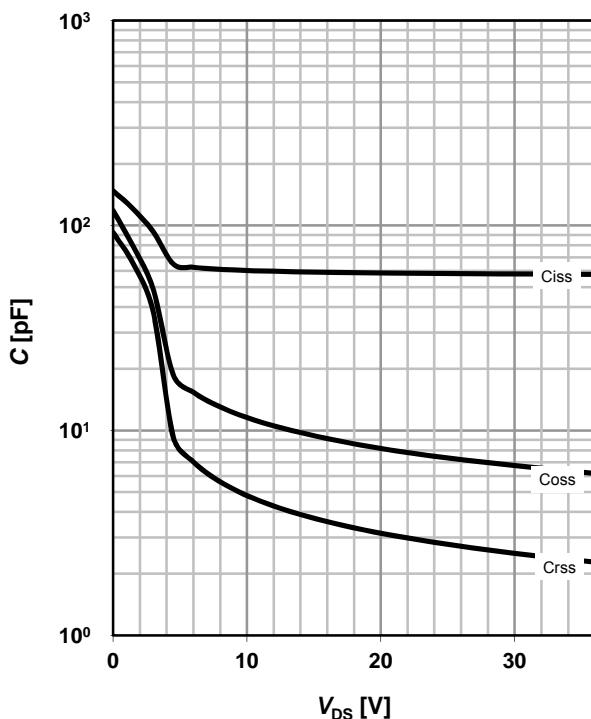
parameter:  $t_p$ 

**4 Max. transient thermal impedance**

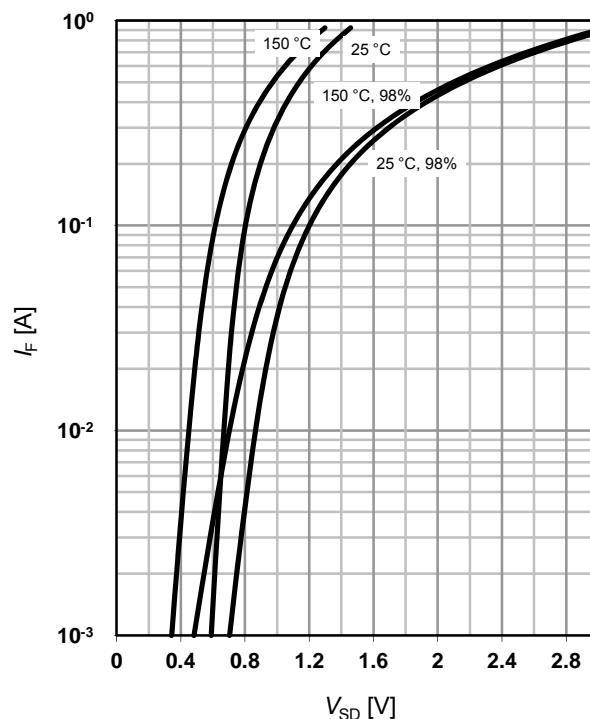
$$Z_{\text{thJA}} = f(t_p)$$

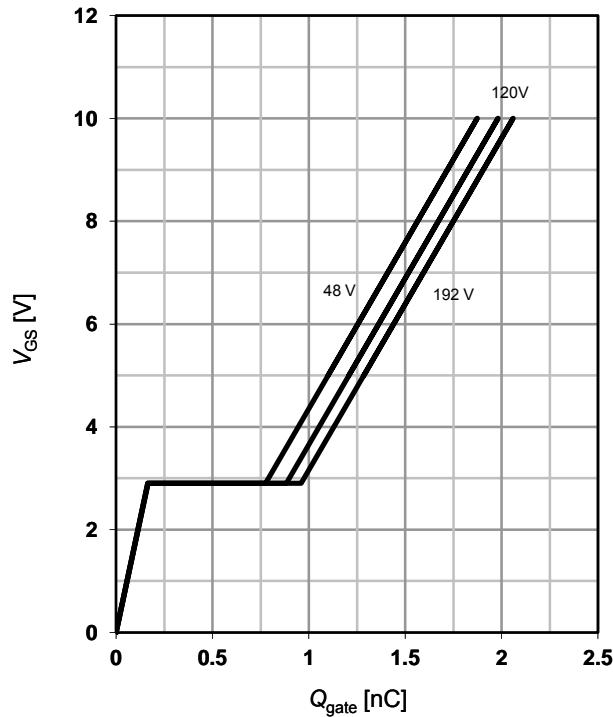
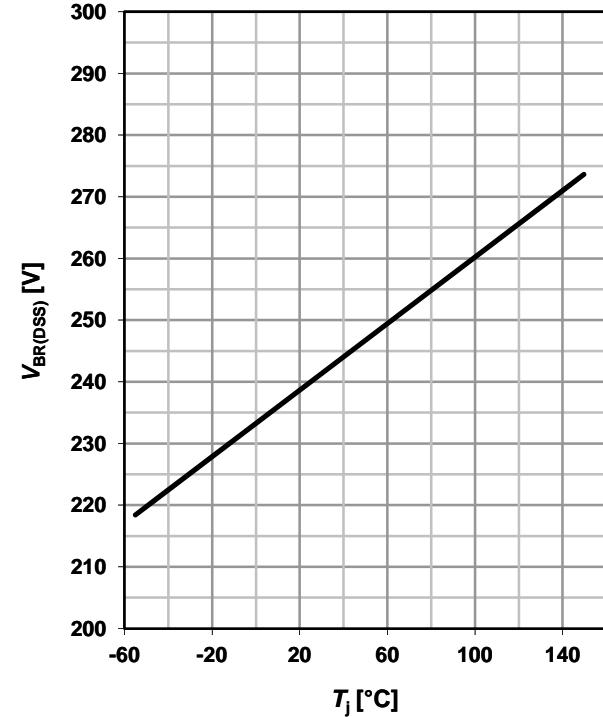
parameter:  $D = t_p/T$ 


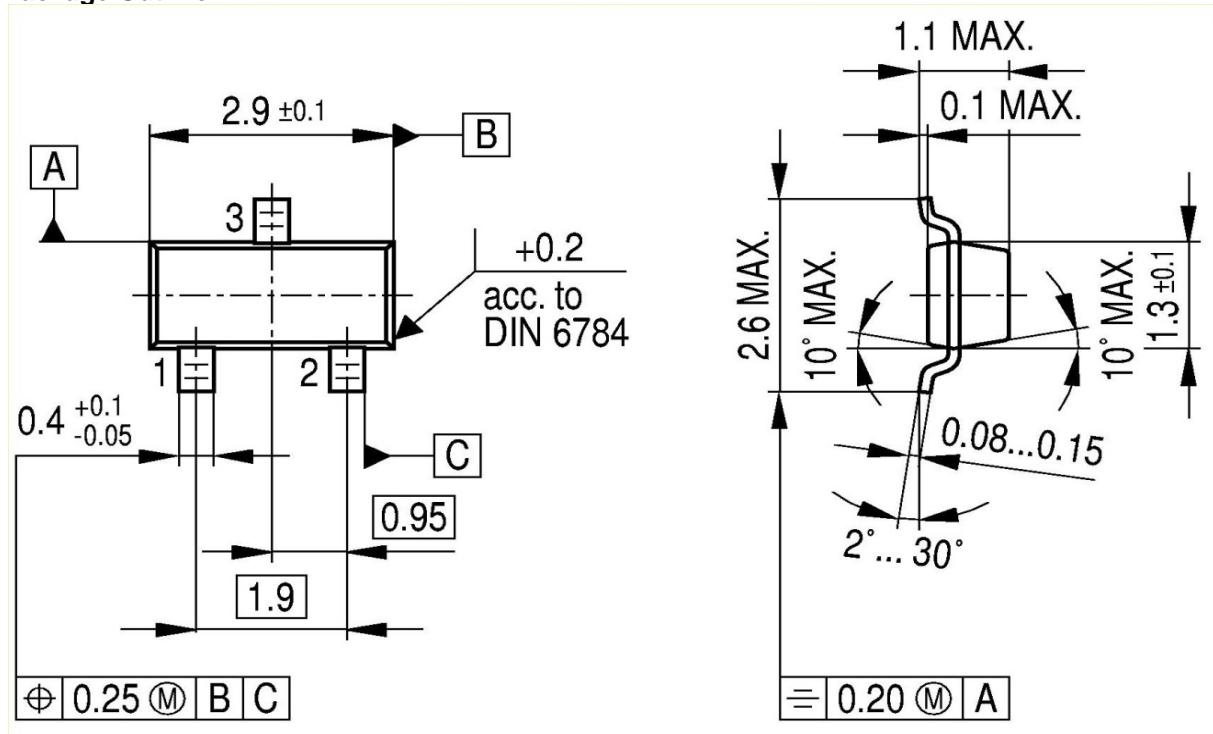
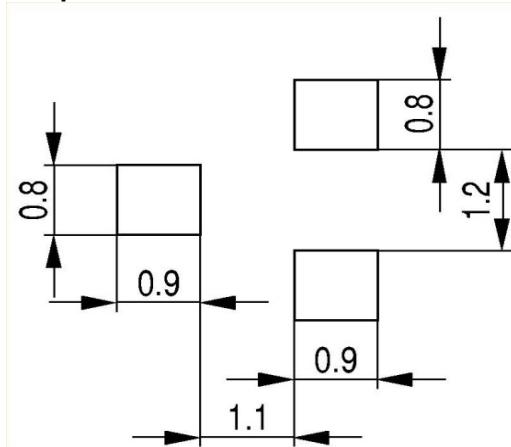
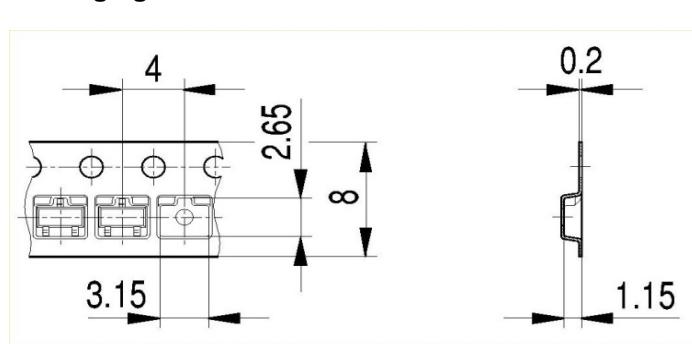
**5 Typ. output characteristics**
 $I_D = f(V_{DS})$ ;  $T_j = 25^\circ\text{C}$ 
parameter:  $V_{GS}$ 
**6 Typ. drain-source on resistance**
 $R_{DS(on)} = f(I_D)$ ;  $T_j = 25^\circ\text{C}$ 
parameter:  $V_{GS}$ 
**7 Typ. transfer characteristics**
 $I_D = f(V_{GS})$ ;  $|V_{DS}| > 2|I_D|R_{DS(on)max}$ 

**8 Typ. forward transconductance**
 $g_{fs} = f(I_D)$ ;  $T_j = 25^\circ\text{C}$ 


**9 Drain-source on-state resistance**
 $R_{DS(on)} = f(T_j); I_D = 0.1 \text{ A}; V_{GS} = 10 \text{ V}$ 

**10 Typ. gate threshold voltage**
 $V_{GS(th)} = f(T_j); V_{DS} = V_{GS}; I_D = 56 \mu\text{A}$ 

parameter:  $I_D$ 

**11 Typ. capacitances**
 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}; T_j = 25^\circ\text{C}$ 

**12 Forward characteristics of reverse diode**
 $I_F = f(V_{SD})$ 

parameter:  $T_j$ 


**13 Typ. gate charge**
 $V_{GS} = f(Q_{gate})$ ;  $I_D = 0.1 \text{ A pulsed}$ 
parameter:  $V_{DD}$ 
**14 Drain-source breakdown voltage**
 $V_{BR(DSS)} = f(T_j)$ ;  $I_D = 250 \mu\text{A}$ 


**Package Outline:**

**Footprint:**

**Packaging:**


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